TOSHIBA Power MOS FET Module Silicon N Channel MOS Type (Four L²-π-MOSV in One)

MP4209

High Power, High Speed Switching Applications
For Printer Head Pin Driver and Pulse Motor Driver
For Solenoid Driver

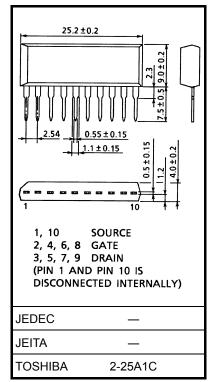
- 4-V gate drivability
- Small package by full molding (SIP 10 pins)
- High drain power dissipation (4-device operation) : $P_T = 4 \text{ W (Ta} = 25^{\circ}\text{C)}$
- Low drain-source ON resistance: RDS (ON) = 0.28Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 3.5 \text{ S (typ.)}$
- Low leakage current: $I_{GSS} = \pm 10 \mu A \text{ (max) (V}_{GS} = \pm 16 \text{ V)}$ $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 100 \text{ V)}$
- Enhancement-mode: $V_{th} = 0.8 \text{ to } 2.0 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	100	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	100	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC	I _D	3	Α	
	Pulse	I _{DP}	12	A	
Drain power dissipation (1-device operation, Ta = 25°C)		P _D	2.0	W	
Drain power dissipation (4device operation, Ta = 25°C)		P _{DT}	4.0	W	
Single pulse avalanche energy (Note 1)		E _{AS}	140	mJ	
Avalanche current		I _{AR}	3	Α	
Repetitive avalanche energy (Note 2)	- device operation	E _{AR}	0.2	mJ	
	4device operation	E _{ART}	0.4		
Channel temperature		T _{ch}	150	°C	
Storage temperature ran	ge	T _{stg}	-55 to 150	°C	

Industrial Applications

Unit: mm



Weight: 2.1 g (typ.)

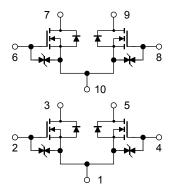
- Note 1: Condition for avalanche energy (single pulse) measurement V_{DD} = 50 V, starting T_{ch} = 25°C, L = 20 mH, R_G = 25 Ω , I_{AR} = 3 A
- Note 2: Repetitive rating; pulse width limited by maximum channel temperature
- Note 3: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Please handle with caution.



Array Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance from channel to ambient	ΣR _{th (ch-a)}	31.2	°C/W	
(4-device operation, Ta = 25°C)	u. (4.1 2)			
Maximum lead temperature for soldering purposes	TL	260	°C	
(3.2 mm from case for t = 10 s)				

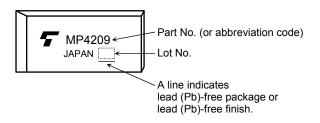
Electrical Characteristics (Ta = 25°C)

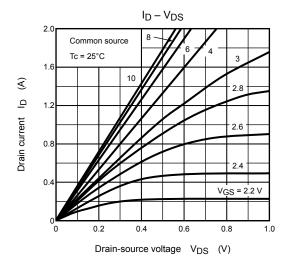
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off curre	ent	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source brea	akdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	100	_	_	V
Gate threshold vo	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V
Drain-source ON resistance		Ppo (ON)	V _{GS} = 4 V, I _D = 2 A	_	0.36	0.45	Ω
		R _{DS} (ON)	V _{GS} = 10 V, I _D = 2 A	_	0.28	0.35	
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2 A	1.5	3.5	ı	S
Input capacitance	•	C _{iss}	V 40.V.V 0.V		280	_	pF
Reverse transfer capacitance Output capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}$ - f = 1 MHz	_	50	_	pF
		Coss		_	105	_	pF
	Rise time	t _r	10 V	_	20	_	
Switching time	Turn-on time ton 0 V 1 1 1 C	255 P	_	50	1	ne	
Fal	Fall time	t _f	V_{IN} : t_{r} , t_{f} < 5 ns, duty \leq 1%, t_{W} = 10 μ s	_	40	ı	ns
	Turn-off time	t _{off}		_	170	-	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 80 V, V _{GS} = 10 V	_	13.5	_	nC
Gate-source charge		Q _{gs}	I _D = 3 A	_	8.5	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	5	_	nC

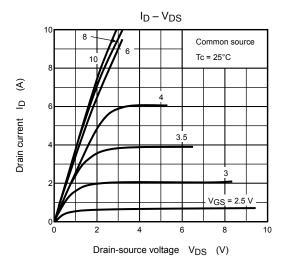
Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

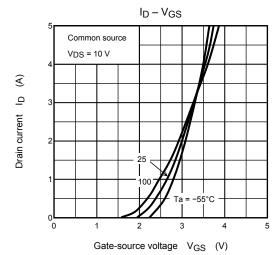
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current	I _{DR}	_	_	_	3	Α
Pulse drain reverse current	I _{DRP}	_	_	_	12	Α
Diode forward voltage	V _{DSF}	I _{DR} = 3 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	I _{DR} = 3 A, V _{GS} = 0 V	_	100	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 50 A/μs	_	0.2	_	μC

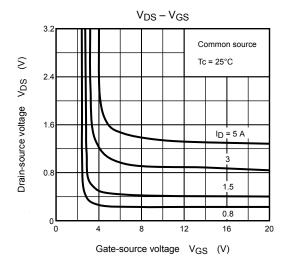
Marking

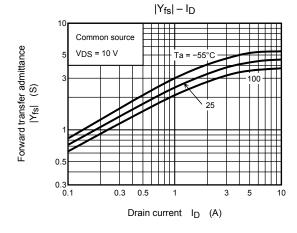


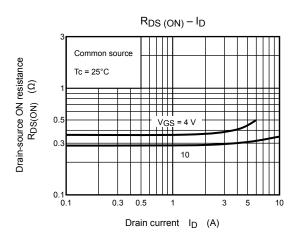


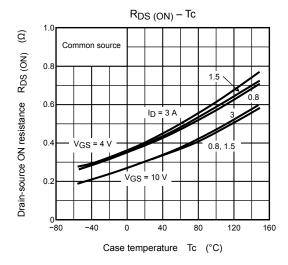


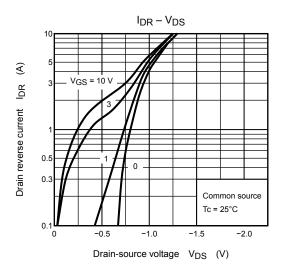


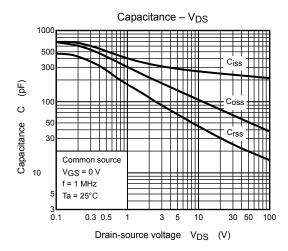


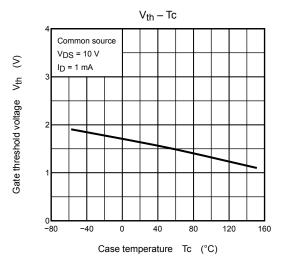


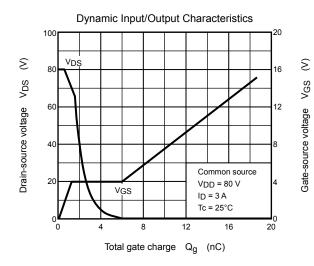


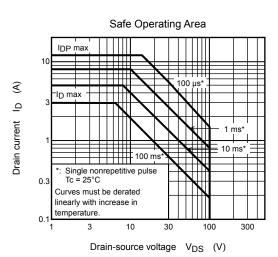




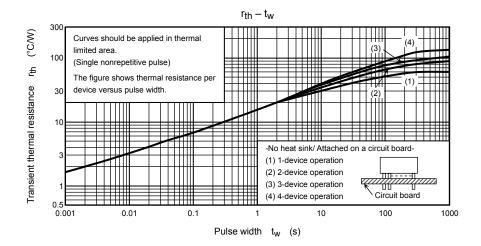


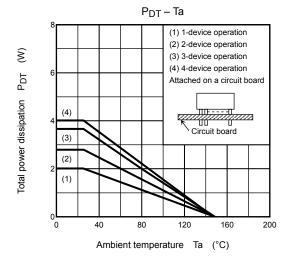


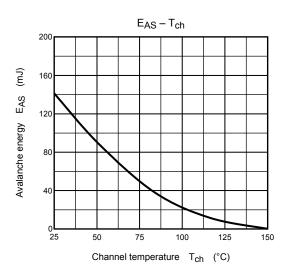


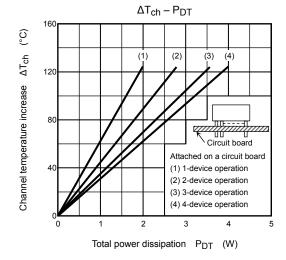


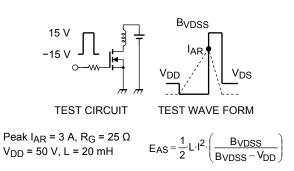
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